

Search Notes

Application/Control No.

09/734,701

Examiner

Ba Huynh

Applicant(s)/Patent under
Reexamination

OKAWA ET AL.

Art Unit

2179

SEARCHED

Class	Subclass	Date	Examiner
715	530	7/5/2005	HB
	531		
	540		
	541		
	770		
	772		
	860		
345	661		
	676		
	650		
382	258		
	309		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
<i>All above 7/5/05 HB</i>			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East: USpat, Epo, Jpo, Derwent, IBM- tdb files search updated	7/5/2005	HB